

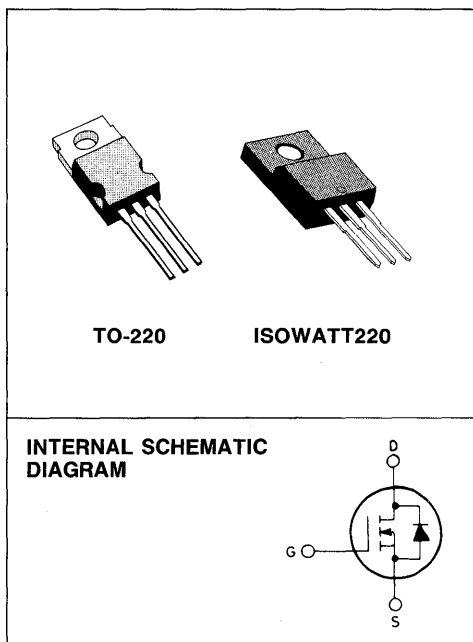
N - CHANNEL ENHANCEMENT MODE LOW THRESHOLD POWER MOS TRANSISTORS

PRELIMINARY DATA

TYPE	V _{DSS}	R _{DS(on)}	I _D
STLT20	60 V	0.15 Ω	15 A
STLT20FI	60 V	0.15 Ω	10 A
STLT19	50 V	0.15 Ω	15 A
STLT19FI	50 V	0.15 Ω	10 A

- LOGIC LEVEL (+5V) CMOS/TTL COMPATIBLE INPUT
- HIGH INPUT IMPEDANCE
- ULTRA FAST SWITCHING

N - channel enhancement mode POWER MOS field effect transistors. The low input voltage - logic level - and easy drive make these devices ideal for automotive and industrial applications. Typical uses are in relay and actuator driving in the automotive environment.



ABSOLUTE MAXIMUM RATINGS

		TO-220 ISOWATT220	STLT20 STLT20FI	STLT19 STLT19FI	
V _{DS}	Drain-source voltage (V _{GS} = 0)		60	50	V
V _{DGR}	Drain-gate voltage (R _{GS} = 20 KΩ)		60	50	V
V _{GS}	Gate-source voltage			± 15	V
I _D	Drain current (cont.) at T _c = 25°C		15	10	A
I _D	Drain current (cont.) at T _c = 100°C		9.5	6.3	A
I _{DM} (*)	Drain current (pulsed)		40	40	A
P _{tot}	Total dissipation at T _c < 25°C		75	30	W
	Derating factor		0.6	0.24	W/°C
T _{stg}	Storage temperature		-65 to 150		°C
T _j	Max. operating junction temperature		150		°C

*) Pulse width limited by safe operating area

THERMAL DATA
TO-220 | ISOWATT220

$R_{th(j-c)}$	Thermal resistance junction-case	max	1.67	4.16	$^{\circ}\text{C}/\text{W}$
T_l	Maximum lead temperature for soldering purpose	max	275		$^{\circ}\text{C}$

ELECTRICAL CHARACTERISTICS ($T_{case} = 25^{\circ}\text{C}$ unless otherwise specified)

Parameters	Test Conditions	Min.	Typ.	Max.	Unit
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OFF

$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 250 \mu\text{A}$ for STLT20/FI for STLT19/FI	$V_{GS} = 0$	60 50		V V
I_{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	$V_{DS} = \text{Max Rating}$ $V_{DS} = \text{Max Rating} \times 0.8$	$T_c = 125^{\circ}\text{C}$		250 1000	μA μA
I_{GSS}	Gate-body leakage current ($V_{DS} = 0$)	$V_{GS} = \pm 15 \text{ V}$			± 100	nA

ON **

$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$	$I_D = 250 \mu\text{A}$	1		2.5 V
$R_{DS(on)}$	Static drain-source on resistance	$V_{GS} = 5 \text{ V}$	$I_D = 7.5 \text{ A}$			0.15 Ω

DYNAMIC

g_{fs}	Forward transconductance	$V_{DS} = 15 \text{ V}$	$I_D = 7.5 \text{ A}$	5		mho
C_{iss}	Input capacitance	$V_{DS} = 25 \text{ V}$ $V_{GS} = 0$	$f = 1 \text{ MHz}$		480	pF
C_{oss}	Output capacitance				170	pF
C_{rss}	Reverse transfer capacitance				40	pF

SWITCHING

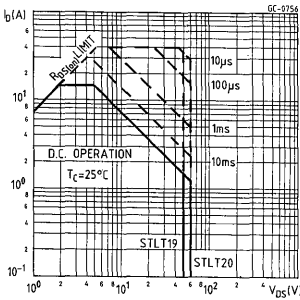
$t_{d(on)}$	Turn-on time	$V_{DD} = 25 \text{ V}$ $V_i = 5 \text{ V}$	$I_D = 7.5 \text{ A}$ $R_i = 50 \Omega$		10	ns
t_r	Rise time				70	ns
$t_{d(off)}$	Turn-off delay time				35	ns
t_f	Fall time				40	ns
Q_g	Total Gate Charge	$V_{DD} = 48 \text{ V}$ $V_{GS} = 5 \text{ V}$	$I_D = 15 \text{ A}$		8 13	nC

ELECTRICAL CHARACTERISTICS (Continued)

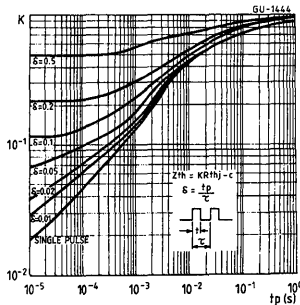
Parameters	Test Conditions	Min.	Typ.	Max.	Unit
I_{SD} $I_{SDM}^{(*)}$	Source-drain current Source-drain current (pulsed)			15 60	A A
V_{SD}^{**}	Forward on voltage	$I_{SD} = 15\text{ A}$	$V_{GS} = 0$	1.25	V
t_{rr}	Reverse recovery time		80		ns
Q_{rr}	Reverse recovered charge	$I_{SD} = 15\text{ A}$	$di/dt = 100\text{ A}/\mu\text{s}$	0.15	μC

** Pulsed: Pulse duration $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$
 (*) Pulse width limited by safe operating area

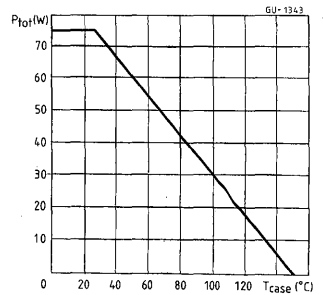
Safe operating areas (standard package)



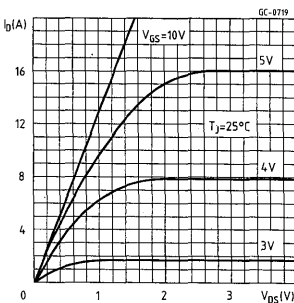
Thermal impedance (standard package)



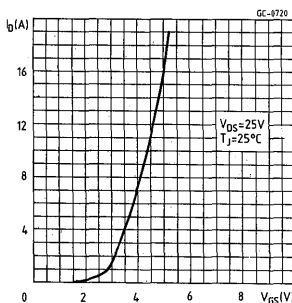
Derating curve (standard package)



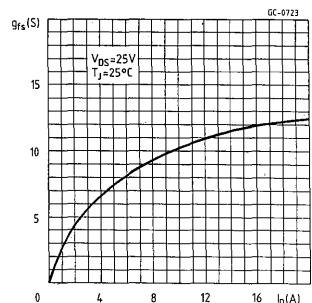
Output characteristics



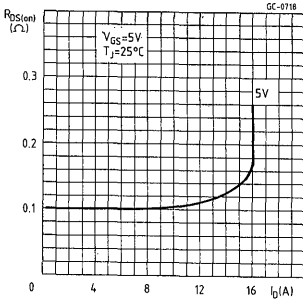
Transfer characteristics



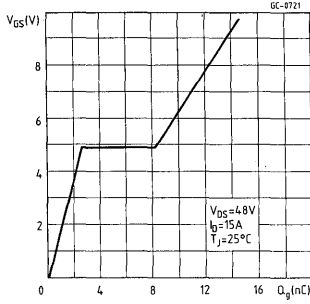
Transconductance



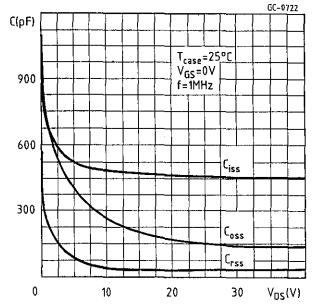
Static drain-source on resistance



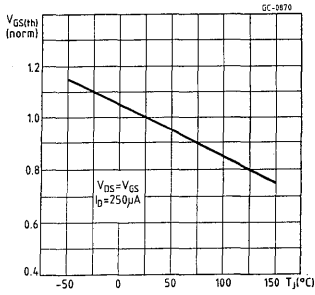
Gate charge vs gate-source voltage



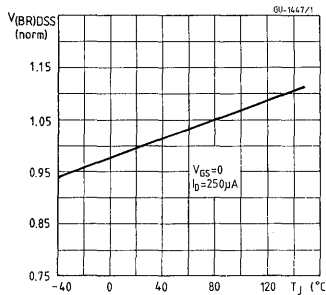
Capacitance variation



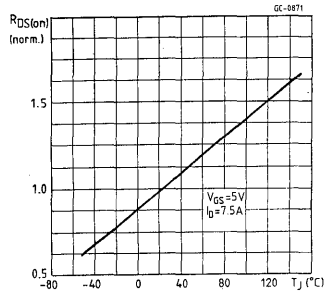
Normalized gate threshold voltage vs temperature



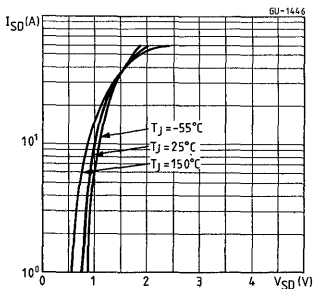
Normalized breakdown voltage vs temperature



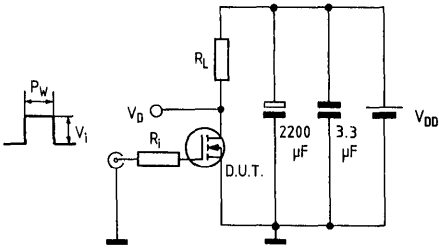
Normalized on resistance vs temperature



Source-drain diode forward characteristics



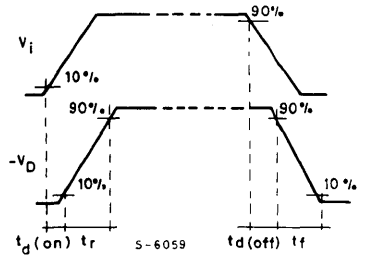
Switching times test circuit for resistive load



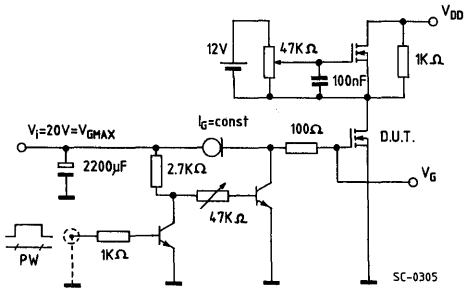
Pulse width $\leq 100 \mu\text{s}$
 Duty cycle $\leq 2\%$

SC-0008/1

Switching time waveforms for resistive load



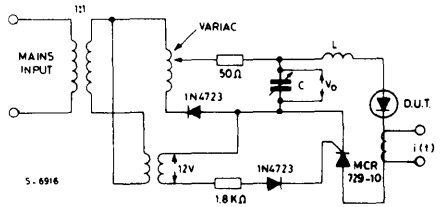
Gate charge test circuit



PW adjusted to obtain required V_G

SC-0305

Body-drain diode t_{rr} measurement
 Jedec test circuit



S. 6916

ISOWATT220 PACKAGE CHARACTERISTICS AND APPLICATION.

ISOWATT220 is fully isolated to 2000V dc. Its thermal impedance, given in the data sheet, is optimised to give efficient thermal conduction together with excellent electrical isolation.

The structure of the case ensures optimum distances between the pins and heatsink. The ISOWATT220 package eliminates the need for external isolation so reducing fixing hardware. Accurate moulding techniques used in manufacture assure consistent heat spreader-to-heatsink capacitance.

ISOWATT220 thermal performance is better than that of the standard part, mounted with a 0.1mm mica washer. The thermally conductive plastic has a higher breakdown rating and is less fragile than mica or plastic sheets. Power derating for ISOWATT220 packages is determined by:

$$P_D = \frac{T_J - T_c}{R_{th}}$$

from this I_{Dmax} for the POWER MOS can be calculated:

$$I_{Dmax} \leq \sqrt{\frac{P_D}{R_{DS(on)} \text{ (at } 150^\circ\text{C)}}$$

THERMAL IMPEDANCE OF ISOWATT220 PACKAGE

Fig. 1 illustrates the elements contributing to the thermal resistance of transistor heatsink assembly, using ISOWATT220 package.

The total thermal resistance $R_{th(tot)}$ is the sum of each of these elements.

The transient thermal impedance, Z_{th} for different pulse durations can be estimated as follows:

1 - for a short duration power pulse less than 1ms;

$$Z_{th} < R_{thJ-C}$$

2 - for an intermediate power pulse of 5ms to 50ms:

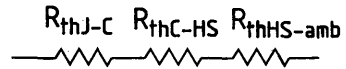
$$Z_{th} = R_{thJ-C}$$

3 - for long power pulses of the order of 500ms or greater:

$$Z_{th} = R_{thJ-C} + R_{thC-HS} + R_{thHS-amb}$$

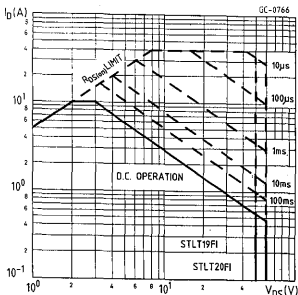
It is often possible to discern these areas on transient thermal impedance curves.

Fig. 1

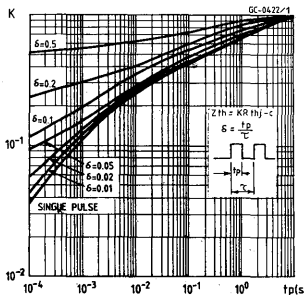


ISOWATT DATA

Safe operating areas



Thermal impedance



Derating curve

